## Notice of References Cited

Application/Control No. 10/048,169	Applicant(s)/Patent Under Reexamination SEITZ, MICHAEL WALTER	
Examiner	Art Unit	
Darren W Gorman	3752	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2,749,176	06-1956	Steyer, Friedrich	239/80
	В	US-3,798,411	03-1974	Wagner, Jaromir	219/136
	С	US-3,901,441	08-1975	Kasagi, Ryoichi	239/81
	D	US-4,492,337	01-1985	Harrington et al.	239/81
	Е	US-4,528,782	07-1985	Bean, George	451/102
	F	US-5,191,186	03-1993	Crapo et al.	219/76.16
	G	US-5,213,848	05-1993	Zurecki et al.	427/449
	Н	US-5,468,295	11-1995	Marantz et al.	118/723DC
	1	US-5,927,604	07-1999	Laidler, Kevin O.	239/104
	J	US-5,932,293	08-1999	Belashchenko et al.	427/446
	К	US-5,964,405	10-1999	Benary et al.	239/84
	L	US-6,245,390	06-2001	Baranovski et al.	427/449
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
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	V			
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.